

<b>Notice of References Cited</b>	Application/Control No. 10/779,789		Applicant(s)/Patent Under Reexamination NAKAYAMA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0120611	06-2003	Yoshino et al.	705/67
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